

<b>Notice of References Cited</b>	Application/Control No. 10/742,891		Applicant(s)/Patent Under Reexamination AIZAWA ET AL.	
	Examiner Jason T. Whipkey		Art Unit 2622	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,862,290 A	08-1989	Jung et al.	386/107
*	B	US-RE34,504 E	01-1994	Uehara et al.	348/65
*	C	US-5,293,236 A	03-1994	Adachi et al.	348/231.2
*	D	US-5,416,560 A	05-1995	Taka, Hideo	396/287
*	E	US-5,473,370 A	12-1995	Moronaga et al.	348/231.1
*	F	US-5,956,084 A	09-1999	Moronaga et al.	348/231.9
*	G	US-2004/0080785 A1	04-2004	Takahashi, Koji	358/001.15
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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